

## 5N40-MTQ

Preliminary

## 5A, 400V N-CHANNEL **POWER MOSFET**

#### DESCRIPTION

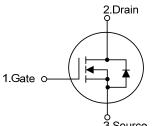
The UTC 5N40-MTQ is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology specializes in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC 5N40-MTQ is universally applied in electronic lamp ballast based on half bridge topology and high efficient switched mode power supply.

#### **FEATURES**

- $* R_{DS(ON)} < 1.6\Omega @ V_{GS} = 10V, I_D = 2.5A$
- \* High switching speed
- \* 100% avalanche tested

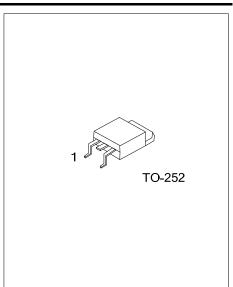
#### **SYMBOL**



3.Source

### **ORDERING INFORMATION**

| Ordering Number  |   | Dealasas | Pin Assignment |   |   | Dealing                 |  |
|--|---|----------|----------------|---|---|-------------------------|--|
| Lead Free  | Halogen Free                                    | Package  | 1              | 2 | 3 | Packing                 |  |
| 5N40L-TN3-R  | 5N40G-TN3-R                                     | TO-252   | G              | D | S | Tape Reel               |  |
| Note: Pin Assignment: G: Gate D: Drain S: Source   |   |          |                |   |   |                         |  |
| 5N40G-TN3-R<br>(1)Packing Type<br>(2)Package Type<br>(2) TN3: TO-252   |   |          |                |   |   |                         |  |
|  | (3) G: Halogen Free and Lead Free, L: Lead Free |          |                |   |   |                         |  |
| MARKING<br>UTC<br>SN40<br>C: Lead Free<br>G: Halogen Free<br>Date Code<br>1<br>UTC<br>SN40<br>C: Lead Free<br>Date Code<br>1<br>UTC<br>SN40<br>Difference<br>Date Code |   |          |                |   |   |                         |  |
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#### ABSOLUTE MAXIMUM RATINGS (Tc=25°C, unless otherwise specified)

| PARAMETER                         |                                   | SYMBOL           | RATINGS    | UNIT |
|-----------------------------------|-----------------------------------|------------------|------------|------|
| Drain-Source Voltage              |                                   | V <sub>DSS</sub> | 400        | V    |
| Gate-Source Voltage               |                                   | V <sub>GSS</sub> | ±30        | V    |
| Drain Current<br>Avalanche Energy | Continuous (T <sub>C</sub> =25°C) | I <sub>D</sub>   | 5          | А    |
|                                   | Pulsed (Note 2)                   | I <sub>DM</sub>  | 10         | А    |
| Avalanche Energy                  | Single Pulsed (Note 3)            | E <sub>AS</sub>  | 116        | mJ   |
| Peak Diode Recovery               | dv/dt (Note 4)                    | dv/dt            | 4.9        | V/ns |
| Power Dissipation                 |                                   | PD               | 50         | W    |
| Junction Temperature              |                                   | TJ               | +150       | °C   |
| Storage Temperature               |                                   | T <sub>STG</sub> | -55 ~ +150 | °C   |

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=18mH,  $I_{AS}$ =3.6A,  $V_{DD}$ =50V,  $R_G$ =25  $\Omega$ , Starting  $T_J$  = 25°C

4.  $I_{SD} \le 5.0A$ , di/dt  $\le 100A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 

#### THERMAL DATA

| PARAMETER           | SYMBOL          | RATINGS | UNIT |  |
|---------------------|-----------------|---------|------|--|
| Junction to Ambient | θ <sub>JA</sub> | 110     | °C/W |  |
| Junction to Case    | θις             | 2.5     | °C/W |  |

#### ELECTRICAL CHARACTERISTICS (T<sub>C</sub>=25°C, unless otherwise specified)

| PARAMETER                                | SYMBOL                     | TEST CONDITIONS  |     | TYP  | MAX  | UNIT |
|--|----------------------------|--|-----|------|------|------|
| OFF CHARACTERISTICS                      |                            |  |     |      |      |      |
| Drain-Source Breakdown Voltage           | BV <sub>DSS</sub>          | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                         | 400 |      |      | V    |
| Drain-Source Leakage Current             | I <sub>DSS</sub>           | V <sub>DS</sub> =400V, V <sub>GS</sub> =0V                         |     |      | 10   | μA   |
| Cate Source Lookage Current Forward      | d I                        | V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V                         |     |      | +100 | nA   |
| Gate- Source Leakage Current Revers      | e I <sub>GSS</sub>         | V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V                         |     |      | -100 | nA   |
| ON CHARACTERISTICS                       |                            |  |     |      | -    |      |
| Gate Threshold Voltage                   | V <sub>GS(TH)</sub>        | $V_{DS}=V_{GS}$ , $I_{D}=250\mu A$                                 |     |      | 4.0  | V    |
| Static Drain-Source On-State Resistance  | R <sub>DS(ON)</sub>        | V <sub>GS</sub> =10V, I <sub>D</sub> =2.5A                         |     | 1.3  | 1.6  | Ω    |
| DYNAMIC PARAMETERS                       |                            |  |     |      | -    |      |
| Input Capacitance                        | C <sub>ISS</sub>           |  |     | 400  |      | рF   |
| Output Capacitance                       | C <sub>OSS</sub>           | V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz                |     | 56   |      | рF   |
| Reverse Transfer Capacitance             | C <sub>RSS</sub>           |  |     | 4.5  |      | рF   |
| SWITCHING PARAMETERS                     |                            |  |     |      | -    |      |
| Total Gate Charge                        | $Q_{G}$                    | V <sub>DS</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =5.0A, |     | 11.5 |      | nC   |
| Gate to Source Charge                    | $Q_{GS}$                   | $I_{G}=1mA$ (Note 1, 2)  |     | 4.9  |      | nC   |
| Gate to Drain Charge                     | $Q_{GD}$                   |  |     | 2.3  |      | nC   |
| Turn-ON Delay Time                       | t <sub>D(ON)</sub>         |  |     | 6    |      | ns   |
| Rise Time                                | t <sub>R</sub>             | V <sub>DS</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =5.0A, |     | 16.4 |      | ns   |
| Turn-OFF Delay Time                      | t <sub>D(OFF)</sub>        | _R <sub>G</sub> =25Ω (Note1,2)                                     |     | 24.6 |      | ns   |
| Fall-Time                                | t <sub>F</sub>             |  |     | 22   |      | ns   |
| SOURCE- DRAIN DIODE RATINGS AN           | D CHARACTERIS              | TICS   |     |      |      |      |
| Maximum Body-Diode Continuous Curre      | nt I <sub>SD</sub>         |  |     |      | 5    | Α    |
| Maximum Body-Diode Pulsed Current        | I <sub>SM</sub>            | TRE DOM  |     |      | 10   | Α    |
| Drain-Source Diode Forward Voltage       | V <sub>SD</sub>            | I <sub>S</sub> =5.0A, V <sub>GS</sub> =0V                          |     |      | 1.5  | V    |
| Reverse Recovery Time (Note 1)           | trr                        | _ls=5.0A, V <sub>GS</sub> =0V, dl⊧/dt=100A/µs                      |     | 205  |      | nS   |
| Reverse Recovery Charge                  | Qrr                        | is=0.0Α, v <sub>GS</sub> =0v, di <sub>F</sub> /dt=100Α/μS          |     | 1.34 |      | μC   |
| Notes: 1. Pulse Test: Pulse width ≤ 300µ | s, Duty cycle $\leq 2\%$ . | FEWINIS  |     |      |      | _    |

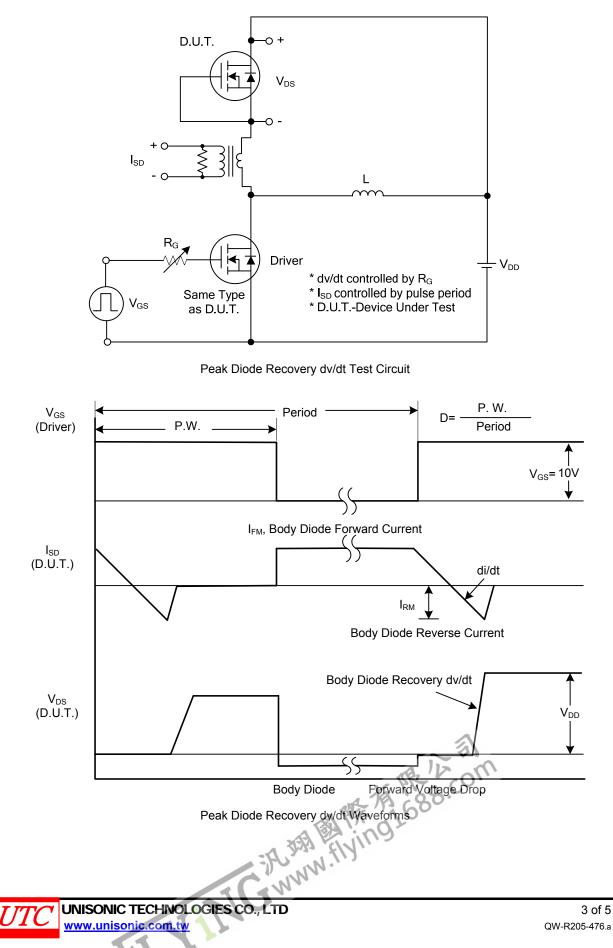
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2. Essentially independent of operating temperature. 'uise width

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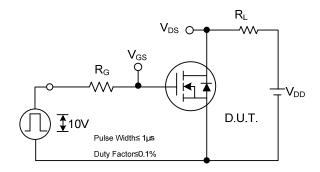
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### TEST CIRCUITS AND WAVEFORMS

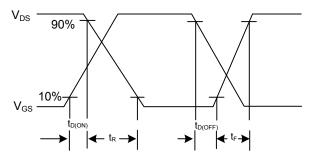


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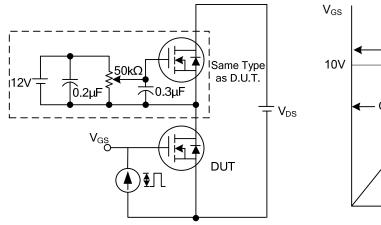
### **TEST CIRCUITS AND WAVEFORMS (Cont.)**



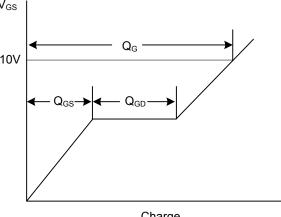




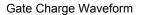
Switching Waveforms

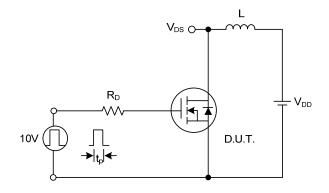


Gate Charge Test Circuit

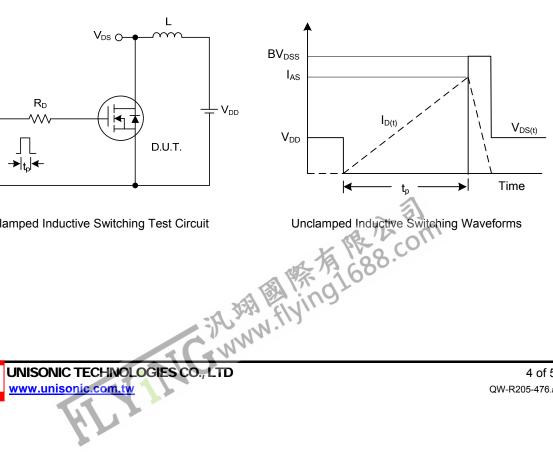


Charge





Unclamped Inductive Switching Test Circuit



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